

# **Device Modeling Report**

COMPONENTS:

DIODE/ GENERAL PURPOSE RECTIFIER/ SATANDARD

PART NUMBER: U1GC44

MANUFACTURER: TOSHIBA

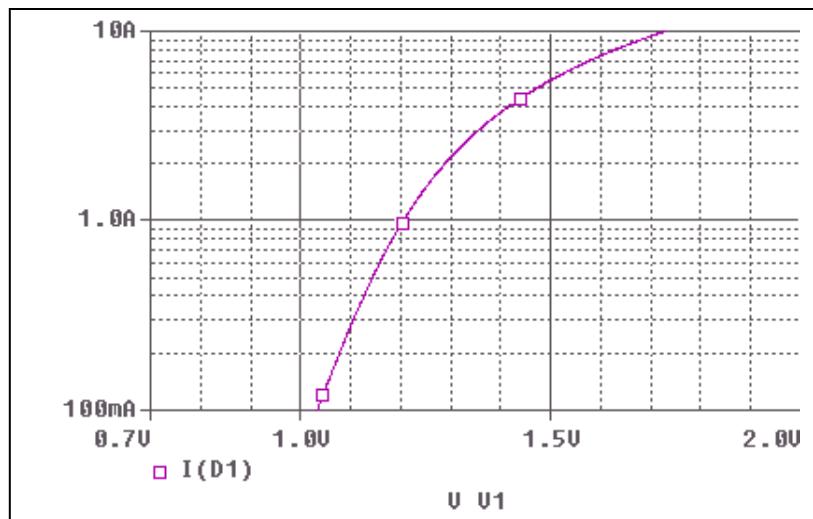


**Bee Technologies Inc.**

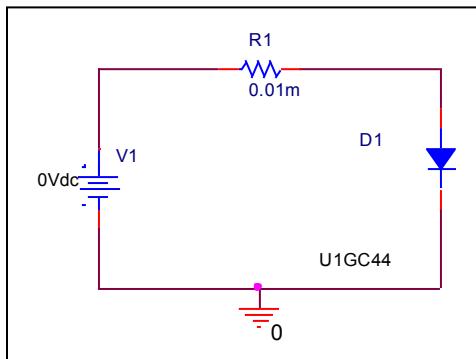
| PSpice model parameter | Model description                           |
|------------------------|---|
| IS                     | Saturation Current                          |
| N                      | Emission Coefficient                        |
| RS                     | Series Resistance                           |
| IKF                    | High-injection Knee Current                 |
| CJO                    | Zero-bias Junction Capacitance              |
| M                      | Junction Grading Coefficient                |
| VJ                     | Junction Potential                          |
| ISR                    | Recombination Current Saturation Value      |
| BV                     | Reverse Breakdown Voltage(a positive value) |
| IBV                    | Reverse Breakdown Current(a positive value) |
| TT                     | Transit Time                                |
| EG                     | Energy-band Gap                             |

## Forward Current Characteristic

Circuit Simulation Result

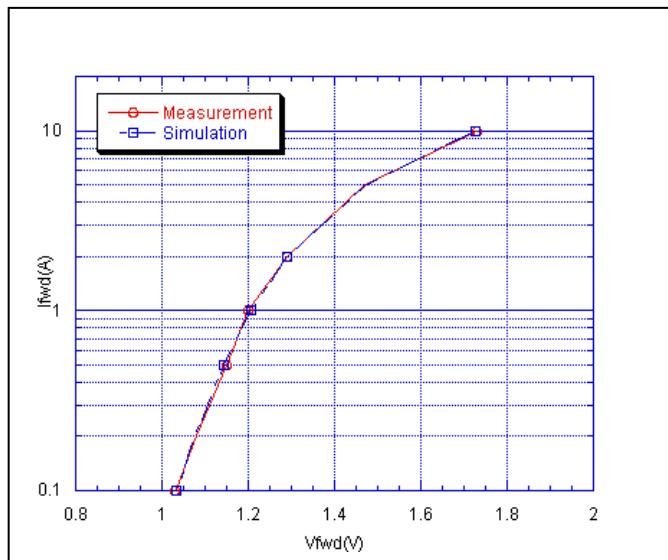


Evaluation Circuit



## Comparison Graph

### Circuit Simulation Result

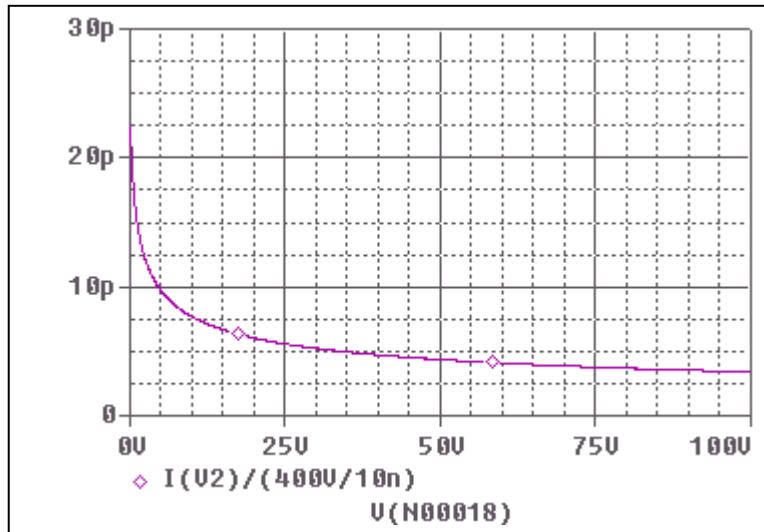


### Simulation Result

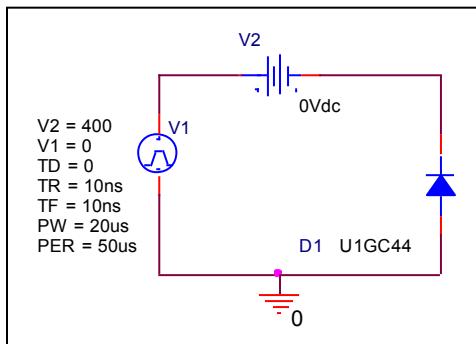
| Ifwd(A) | Vfwd(V)<br>Measurement | Vfwd(V)<br>Simulation | %Error |
|---------|------------------------|-----------------------|--------|
| 0.1     | 1.030                  | 1.034                 | -0.340 |
| 0.2     | 1.080                  | 1.078                 | 0.204  |
| 0.5     | 1.150                  | 1.144                 | 0.539  |
| 1       | 1.200                  | 1.205                 | -0.442 |
| 2       | 1.290                  | 1.289                 | 0.054  |
| 5       | 1.470                  | 1.472                 | -0.143 |
| 10      | 1.730                  | 1.728                 | 0.098  |

## Junction Capacitance Characteristic

### Circuit Simulation Result

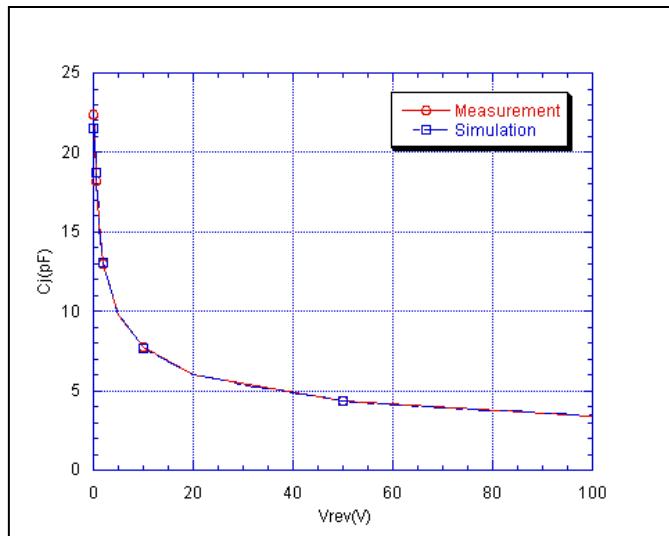


### Evaluation Circuit



## Comparison Graph

### Circuit Simulation Result

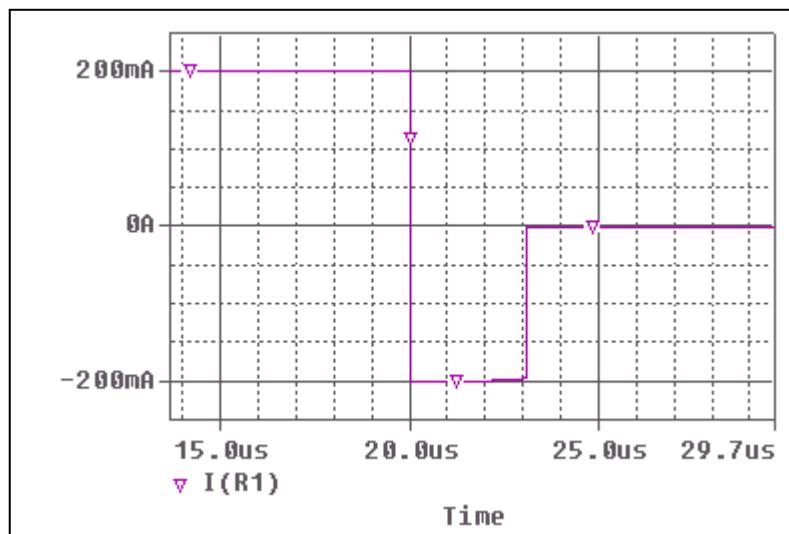


### Simulation Result

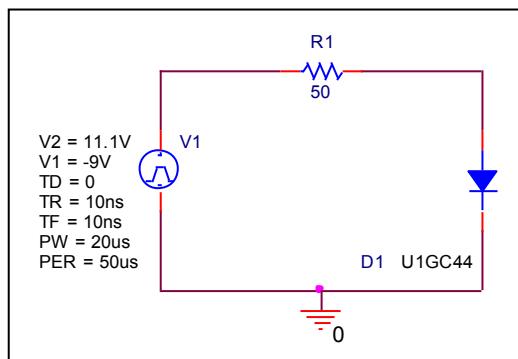
| $V_{rev}(V)$ | $C_j(pF)$<br>Measurement | $C_j(pF)$<br>Simulation | %Error |
|--------------|--------------------------|-------------------------|--------|
| 0            | 24.058                   | 24.058                  | 0.000  |
| 0.1          | 22.361                   | 21.524                  | 3.743  |
| 0.2          | 21.065                   | 21.777                  | -3.380 |
| 0.5          | 18.226                   | 18.738                  | -2.809 |
| 1            | 15.671                   | 15.913                  | -1.544 |
| 2            | 13.005                   | 13.081                  | -0.584 |
| 5            | 9.802                    | 9.738                   | 0.649  |
| 10           | 7.725                    | 7.679                   | 0.599  |
| 20           | 5.982                    | 6.031                   | -0.819 |
| 50           | 4.366                    | 4.357                   | 0.213  |
| 100          | 3.327                    | 3.398                   | -2.158 |

## Reverse Recovery Characteristic

### Circuit Simulation Result



### Evaluation Circuit

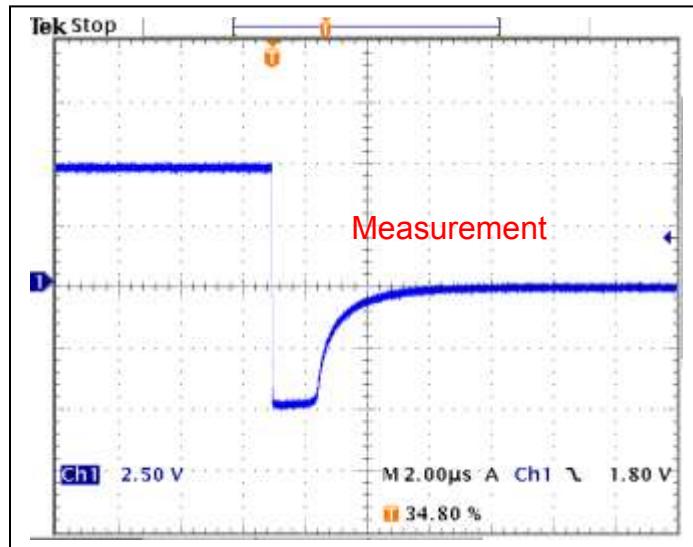


### Compare Measurement vs. Simulation

|     | Measurement |    | Simulation |    | %Error |
|-----|-------------|----|------------|----|--------|
| trr | 3.08        | us | 3.06       | us | 0.649  |

## Reverse Recovery Characteristic

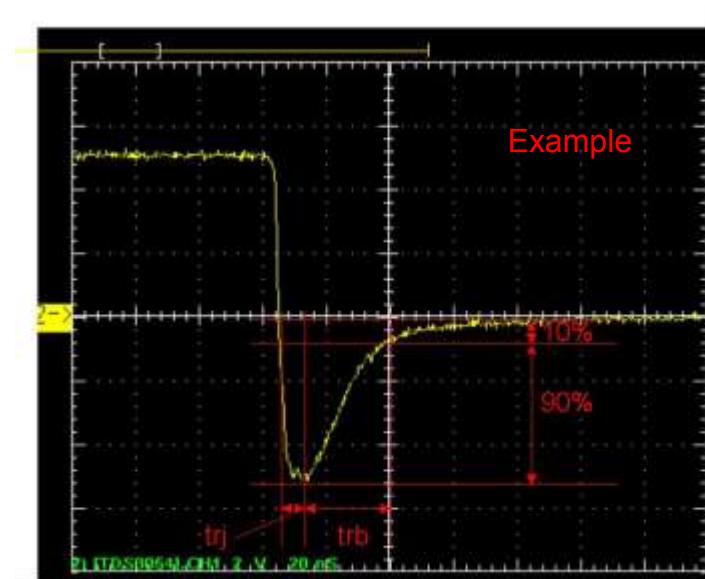
## Reference



Trj = 1.32(μs)

Trb=1.76μs)

Conditions: Ifwd=Irev=0.2(A), RI=50



Relation between trj and trb